**Product data sheet** 

### 1. General description

Planar passivated three quadrant triac in a SOT428 (DPAK) surface-mountable plastic package. This "series D" triac balances the requirements of commutation performance and gate sensitivity and is intended for interfacing with low power drivers and logic ICs including microcontrollers.

#### 2. Features and benefits

- 3Q technology for improved noise immunity
- Direct gate triggering from low power drivers and logic ICs
- High blocking voltage capability
- High commutation capability with very sensitive gate
- Planar passivated for voltage ruggedness and reliability
- Surface-mountable package
- Triggering in three quadrants only
- · Very sensitve gate for easy logic level triggering

## 3. Applications

- AC solenoids
- General purpose motor control circuits
- Home appliances

#### 4. Quick reference data

Table 1. Quick reference data

| Symbol              | Parameter                                | Conditions  |  | Min | Тур | Max | Unit |
|---------------------|--|---|--|-----|-----|-----|------|
| $V_{DRM}$           | repetitive peak off-<br>state voltage    |   |  | -   | -   | 600 | V    |
| I <sub>TSM</sub>    | non-repetitive peak on-<br>state current | full sine wave; $T_{j(init)} = 25 \text{ °C}$ ;<br>$t_p = 20 \text{ ms}$ ; Fig. 4; Fig. 5 |  | -   | -   | 25  | Α    |
| I <sub>T(RMS)</sub> | RMS on-state current                     | full sine wave; $T_{mb} \le 107$ °C; Fig. 1;<br>Fig. 2; Fig. 3                            |  | -   | -   | 4   | А    |
| Static characte     | Static characteristics                   |   |  |     |     |     |      |
| I <sub>GT</sub>     | gate trigger current                     | $V_D = 12 \text{ V}; I_T = 0.1 \text{ A}; T2+ G+;$<br>$T_j = 25 \text{ °C}; Fig. 7$       |  | -   | -   | 5   | mA   |





**3Q Hi-Com Triac** 

| Symbol | Parameter | Conditions   | Min | Тур | Max | Unit |
|--------|-----------|--|-----|-----|-----|------|
|        |           | $V_D = 12 \text{ V; } I_T = 0.1 \text{ A; } T2+ \text{ G-;}$<br>$T_j = 25 \text{ °C; } Fig. 7$             | -   | -   | 5   | mA   |
|        |           | $V_D = 12 \text{ V}; I_T = 0.1 \text{ A}; T2- \text{G-};$<br>$T_j = 25 \text{ °C}; \frac{\text{Fig. 7}}{}$ | -   | -   | 5   | mA   |

# 5. Pinning information

Table 2. Pinning information

| Pin | Symbol | Description                    | Simplified outline | Graphic symbol |
|-----|--------|--------------------------------|--------------------|----------------|
| 1   | T1     | main terminal 1                | mb                 | T2—T1          |
| 2   | T2     | main terminal 2                |                    | sym051         |
| 3   | G      | gate                           |                    | ·              |
| mb  | T2     | mounting base; main terminal 2 | 1 3  DPAK (SOT428) |                |

# 6. Ordering information

Table 3. Ordering information

| Type number  | Package |   |         |  |  |  |
|--------------|---------|---|---------|--|--|--|
|              | Name    | Description   | Version |  |  |  |
| BTA204S-600D | DPAK    | plastic single-ended surface-mounted package (DPAK); 3 leads (one lead cropped) | SOT428  |  |  |  |

## 7. Limiting values

Table 4. Limiting values

In accordance with the Absolute Maximum Rating System (IEC 60134).

| Symbol              | Parameter                            | Conditions  | Min | Max | Unit             |
|---------------------|--------------------------------------|---|-----|-----|------------------|
| $V_{DRM}$           | repetitive peak off-state voltage    |   | -   | 600 | V                |
| I <sub>T(RMS)</sub> | RMS on-state current                 | full sine wave; T <sub>mb</sub> ≤ 107 °C; <u>Fig. 1;</u><br><u>Fig. 2; Fig. 3</u>         | -   | 4   | Α                |
| I <sub>TSM</sub>    | non-repetitive peak on-state current | full sine wave; $T_{j(init)} = 25 \text{ °C}$ ;<br>$t_p = 20 \text{ ms}$ ; Fig. 4; Fig. 5 | -   | 25  | Α                |
|                     |                                      | full sine wave; $T_{j(init)} = 25 ^{\circ}C$ ;<br>$t_p = 16.7  \text{ms}$                 | -   | 27  | Α                |
| l <sup>2</sup> t    | I2t for fusing                       | t <sub>p</sub> = 10 ms; SIN   | -   | 3.1 | A <sup>2</sup> s |
| dI <sub>T</sub> /dt | rate of rise of on-state current     | $I_T = 6 \text{ A}$ ; $I_G = 0.2 \text{ A}$ ; $dI_G/dt = 0.2 \text{ A/}\mu\text{s}$       | -   | 100 | A/µs             |
| I <sub>GM</sub>     | peak gate current                    |   | -   | 2   | Α                |
| $P_{GM}$            | peak gate power                      |   | -   | 5   | W                |
| $P_{G(AV)}$         | average gate power                   | over any 20 ms period   | -   | 0.5 | W                |
| T <sub>stg</sub>    | storage temperature                  |   | -40 | 150 | °C               |
| Tj                  | junction temperature                 |   | -   | 125 | °C               |

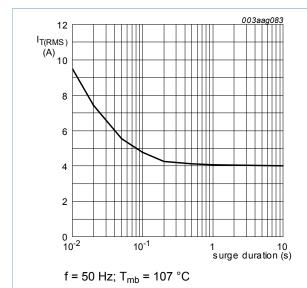


Fig. 1. RMS on-state current as a function of surge duration; maximum values

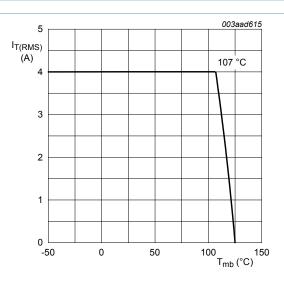


Fig. 2. RMS on-state current as a function of mounting base temperature; maximum values

#### **3Q Hi-Com Triac**

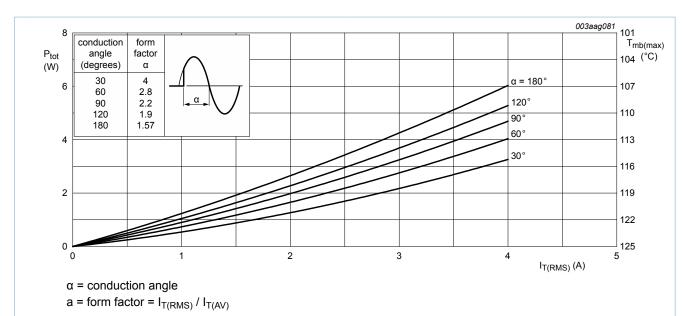


Fig. 3. Total power dissipation as a function of RMS on-state current; maximum values

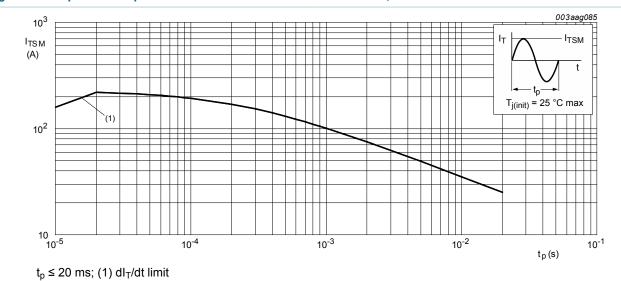


Fig. 4. Non-repetitive peak on-state current as a function of pulse width; maximum values

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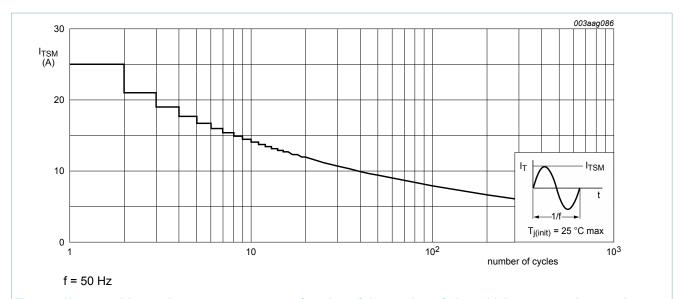


Fig. 5. Non-repetitive peak on-state current as a function of the number of sinusoidal current cycles; maximum values

### 8. Thermal characteristics

Table 5. Thermal characteristics

| Symbol                | Parameter   | Conditions                          | Min | Тур | Max | Unit |
|-----------------------|---|-------------------------------------|-----|-----|-----|------|
| R <sub>th(j-mb)</sub> | thermal resistance<br>from junction to<br>mounting base | full cycle; Fig. 6                  | -   | -   | 3   | K/W  |
|                       |   | half cycle; Fig. 6                  | -   | -   | 3.7 | K/W  |
| R <sub>th(j-a)</sub>  | thermal resistance<br>from junction to<br>ambient       | printed circuit board (FR4) mounted | -   | 75  | -   | K/W  |

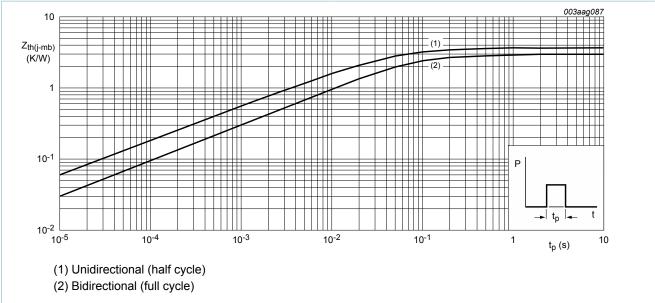


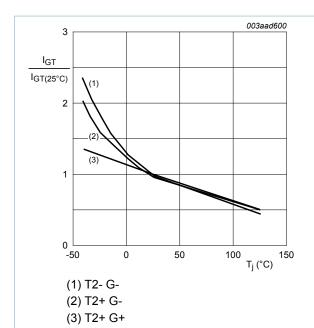
Fig. 6. Transient thermal impedance from junction to mounting base as a function of pulse width

## 9. Characteristics

Table 6. Characteristics

| Symbol                | Parameter                             | Conditions  | Min  | Тур | Max | Unit |
|-----------------------|---------------------------------------|---|------|-----|-----|------|
| Static chara          | acteristics                           |   | '    |     |     |      |
| I <sub>GT</sub>       | gate trigger current                  | $V_D = 12 \text{ V; } I_T = 0.1 \text{ A; } T2+ G+;$<br>$T_j = 25 \text{ °C; } Fig. 7$                    | -    | -   | 5   | mA   |
|                       |                                       | $V_D = 12 \text{ V}; I_T = 0.1 \text{ A}; T2+ \text{ G-};$<br>$T_j = 25 \text{ °C}; Fig. 7$               | -    | -   | 5   | mA   |
|                       |                                       | $V_D = 12 \text{ V}; I_T = 0.1 \text{ A}; T2- \text{G-};$<br>$T_j = 25 \text{ °C}; Fig. 7$                | -    | -   | 5   | mA   |
| IL                    | latching current                      | $V_D = 12 \text{ V}; I_G = 0.1 \text{ A}; T2+ G+;$<br>$T_j = 25 \text{ °C}; Fig. 8$                       | -    | -   | 6   | mA   |
|                       |                                       | $V_D = 12 \text{ V}; I_G = 0.1 \text{ A}; T2+ G-;$<br>$T_j = 25 \text{ °C}; Fig. 8$                       | -    | -   | 9   | mA   |
|                       |                                       | $V_D = 12 \text{ V}; I_G = 0.1 \text{ A}; \text{ T2- G-};$<br>$T_j = 25 ^{\circ}\text{C}; \text{ Fig. 8}$ | -    | -   | 6   | mA   |
| I <sub>H</sub>        | holding current                       | V <sub>D</sub> = 12 V; T <sub>j</sub> = 25 °C; <u>Fig. 9</u>  | -    | -   | 6   | mA   |
| V <sub>T</sub>        | on-state voltage                      | I <sub>T</sub> = 5 A; T <sub>j</sub> = 25 °C; <u>Fig. 10</u>  | -    | 1.4 | 1.7 | V    |
| $V_{\mathrm{GT}}$     | gate trigger voltage                  | $V_D = 12 \text{ V}; I_T = 0.1 \text{ A}; T_j = 25 \text{ °C};$<br>Fig. 11                                | -    | 0.7 | 1   | V    |
|                       |                                       | V <sub>D</sub> = 400 V; I <sub>T</sub> = 0.1 A; T <sub>j</sub> = 125 °C;<br>Fig. 11                       | 0.25 | 0.4 | -   | V    |
| I <sub>D</sub>        | off-state current                     | V <sub>D</sub> = 600 V; T <sub>j</sub> = 125 °C   | -    | 0.1 | 0.5 | mA   |
| Dynamic ch            | naracteristics                        |   |      |     |     |      |
| dV <sub>D</sub> /dt   | rate of rise of off-state voltage     | $V_{DM}$ = 402 V; $T_j$ = 125 °C; $(V_{DM}$ = 67% of $V_{DRM}$ ); exponential waveform; gate open circuit | 20   | -   | -   | V/µs |
| dl <sub>com</sub> /dt | rate of change of commutating current | $V_D$ = 400 V; $T_j$ = 125 °C; $I_{T(RMS)}$ = 4 A; $dV_{com}/dt$ = 10 V/ $\mu$ s; gate open circuit       | 1.1  | -   | -   | A/ms |
|                       |                                       | $V_D$ = 400 V; $T_j$ = 125 °C; $I_{T(RMS)}$ = 4 A; $dV_{com}/dt$ = 0.1 V/ $\mu$ s; gate open circuit      | 4.5  | -   | -   | A/ms |

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3 003aad604

I<sub>L</sub>

I<sub>L(25°C)</sub>

2

1

0

-50

0

50

100

T<sub>j</sub> (°C)

Fig. 8. Normalized latching current as a function of junction temperature

Fig. 7. Normalized gate trigger current as a function of junction temperature

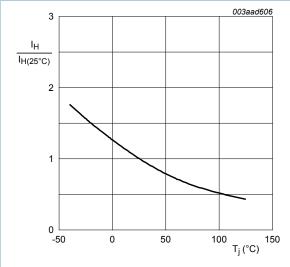
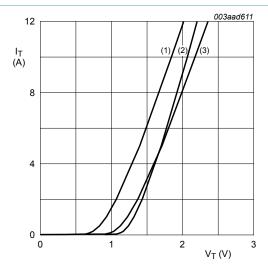


Fig. 9. Normalized holding current as a function of junction temperature



 $V_{o}$  = 1.27 V;  $R_{s}$  = 0.091  $\Omega$ 

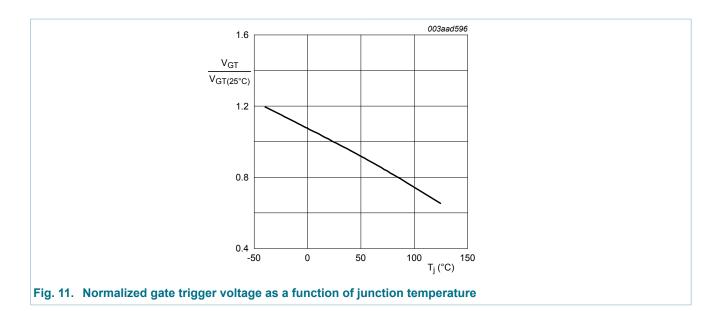
(1) T<sub>j</sub> = 125 °C; typical values

(2) T<sub>i</sub> = 125 °C; maximum values

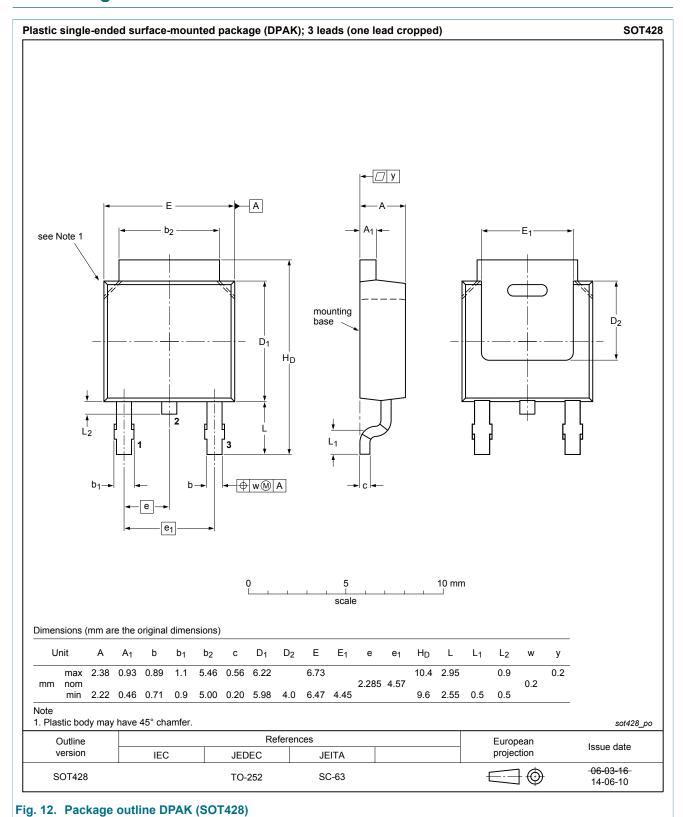
(3) T<sub>i</sub> = 25 °C; maximum values

Fig. 10. On-state current as a function of on-state voltage

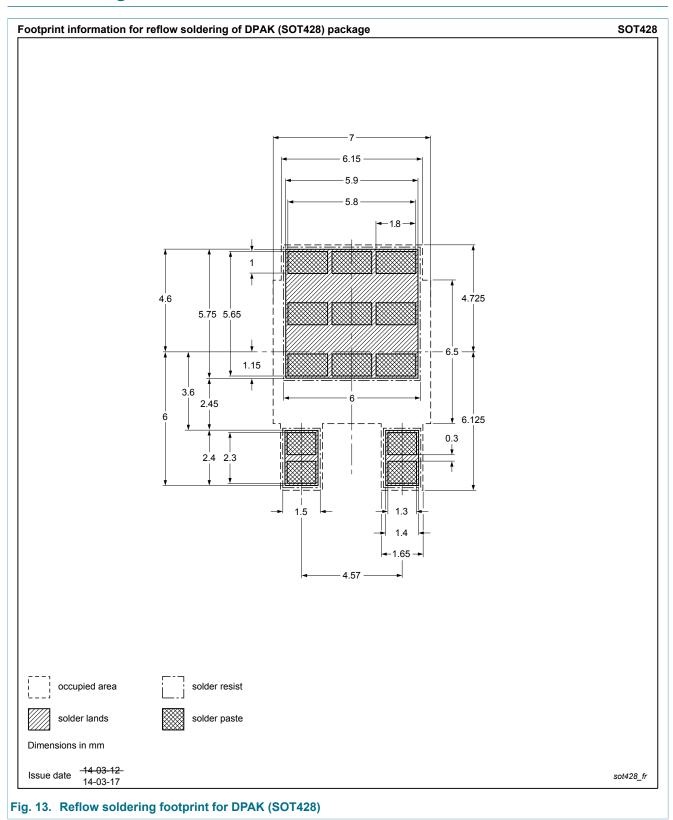
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## 10. Package outline



# 11. Soldering



BTA204S-600D

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